Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/725,242	YOSHIOKA ET AL.
Examiner	Art Unit

Vanel Frenel

3627

					
	SEARCHED				
Class	Subclass	Date	Examiner		
705	26	3/15/2007	V.F		
342	457	3/15/2007	V.Ę		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
705	26	3/15/2007	V.F	
342	457	3/15/2007	V.F	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
West 2.0	3/15/2007	V.F	
STIC	3/12/2007	V.F	